Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

# 2SK3437

# DC-DC Converter, Relay Drive and Motor Drive Applications

- Low drain-source ON resistance: RDS (ON) =  $0.74 \Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 4.5 \text{ S (typ.)}$
- Low leakage current:  $IDSS = 100 \mu A (max) (VDS = 600 V)$
- Enhancement mode:  $V_{th} = 3.0 \sim 5.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

### Maximum Ratings (Ta = 25°C)

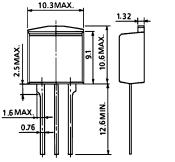
Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	600	V	
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		$V_{DGR}$	600	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	10	А	
	Pulse (Note 1)	I <sub>DP</sub>	30		
Drain power dissipation (Tc = 25°C)		P <sub>D</sub>	80	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	252	mJ	
Avalanche current		I <sub>AR</sub>	10	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	8	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

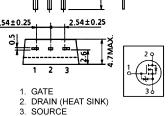
#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.56	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2:  $V_{DD} = 90 \text{ V}$ ,  $T_{ch} = 25^{\circ}\text{C}$  (initial), L = 4.41 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = 10 \text{ A}$
- Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



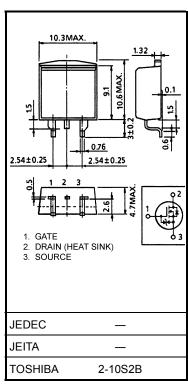


JEDEC —

JEITA —

TOSHIBA 2-10S1B

Weight: 1.5 g (typ.)



Weight: 1.5 g (typ.)



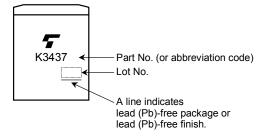
## Electrical Characteristics (Ta = 25°C)

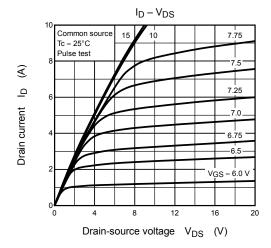
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-OFF cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	100	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	600	_	_	V
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	3.0	_	5.0	٧
Drain-source ON	resistance	R <sub>DS</sub> (ON)	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	_	0.74	1.0	Ω
Forward transfer	admittance	Y <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 5 \text{ A}$	2.0	4.5	_	S
Input capacitance	)	C <sub>iss</sub>		_	1200	_	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	10	_	pF
Output capacitance		C <sub>oss</sub>		_	130		
Switching time	Rise time	t <sub>r</sub>	$V_{GS}^{10 \text{ V}} V_{GS}^{10 \text{ V}} V_{DD}^{10 \text{ S}} = 5 \text{ A} V_{OUT}^{10 \text{ V}} V_{DD}^{10 \text{ S}} = 60 \Omega$ $V_{GS}^{10 \text{ V}} V_{DD}^{10 \text{ S}} = 300 \text{ V}$ $V_{DD}^{10 \text{ V}} = 10  \mu\text{s}$	_	13		- ns
	Turn-ON time	t <sub>on</sub>		_	40	_	
	Fall time	t <sub>f</sub>		_	8		
	Turn-OFF time	t <sub>off</sub>		_	50	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	28	_	nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	_	16	_	
Gate-drain ("miller") charge		Q <sub>gd</sub>		_	12	_	

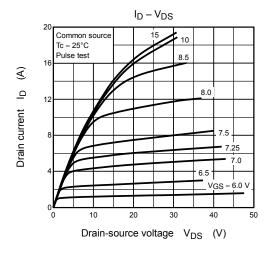
## Source-Drain Ratings and Characteristics (Ta = 25°C)

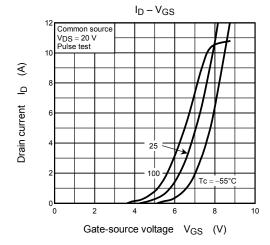
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	$I_{DR}$	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	30	Α
Forward voltage (diode)	V <sub>DSF</sub>	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V},$	_	1600	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 100 A/μs	_	17	_	μС

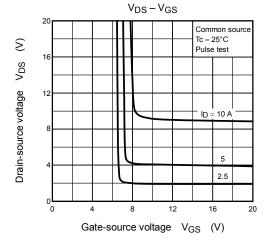
### Marking

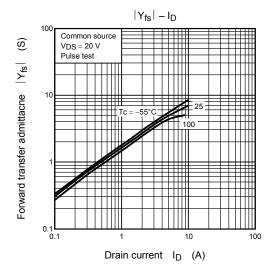


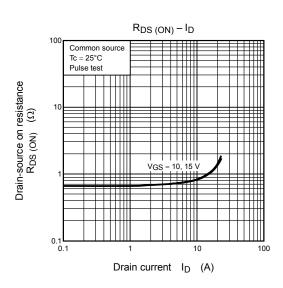




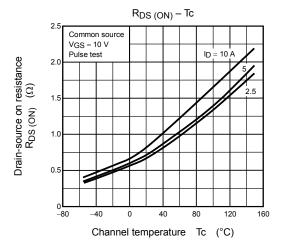


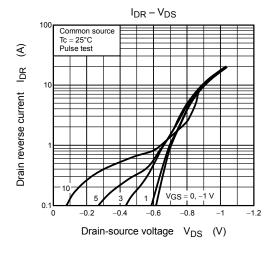


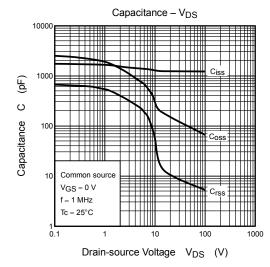


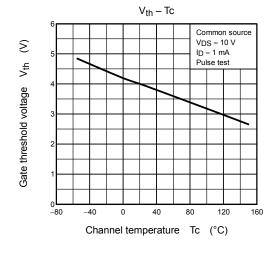


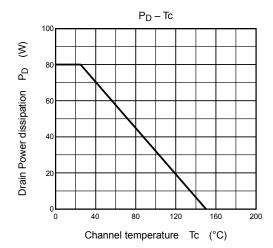
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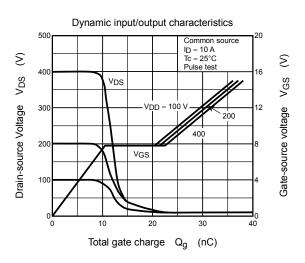




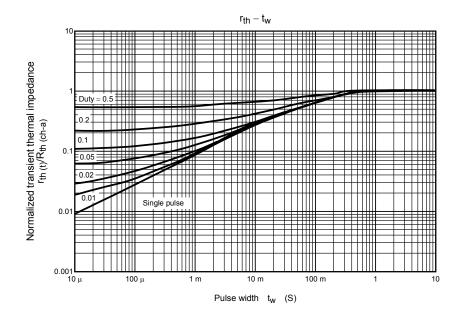


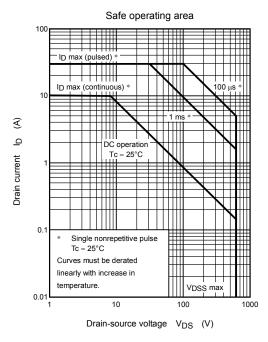


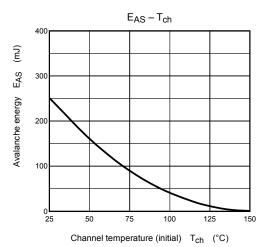


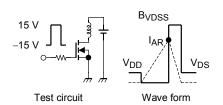


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$$R_G = 25 \Omega$$
  
 $V_{DD} = 90 \text{ V}, L = 4.41 \text{ mH}$ 

$$\mathsf{EAS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{\mathsf{BVDSS}}{\mathsf{BVDSS} - \mathsf{VDD}} \right)$$

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### **RESTRICTIONS ON PRODUCT USE**

Handbook" etc..

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